

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination OHBA, AKITOMO	
		Examiner BENJAMIN E. LANIER	Art Unit 2132	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,130,867	10-2006	Luke, James Steven	707/200
	B	US-			
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	D	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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